

Towards unified robustness against both backdoor and adversarial attacks

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IEEE transactions on pattern analysis and machine intelligence

2024; ePub(ePub):ePub

ARTICLE IDENTIFIERS

DOI: 10.1109/TPAMI.2024.3392760

PMID: 38652616

PMCID: not available

JOURNAL IDENTIFIERS

LCCN: not available

pISSN: 0162-8828

eISSN: 1939-3539

OCLC ID: not available

CONS ID: not available

US National Library of Medicine ID: not available

This article was identified from a query of the SafetyLit database.